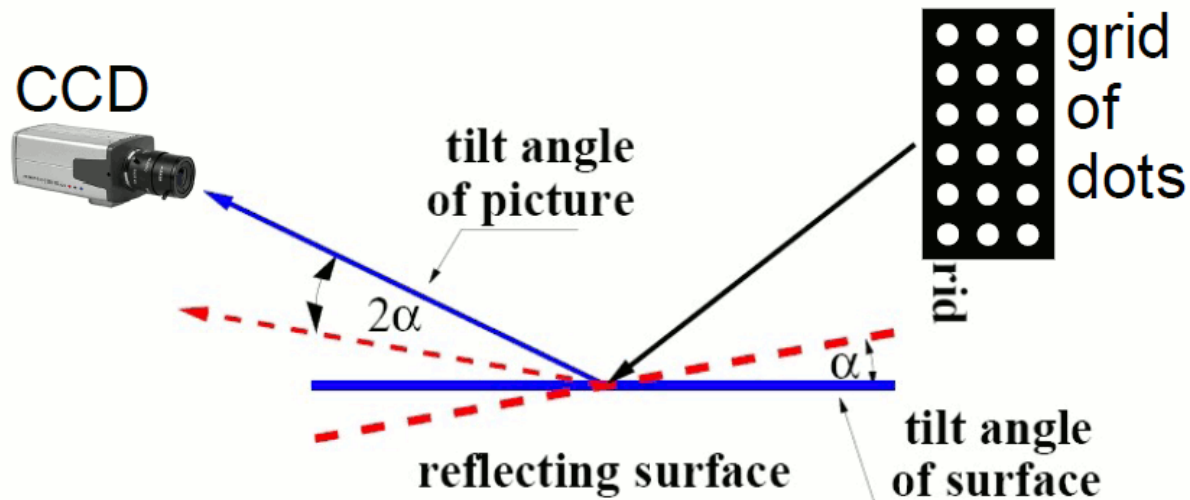


optical deformation measurements -
setup plans & software

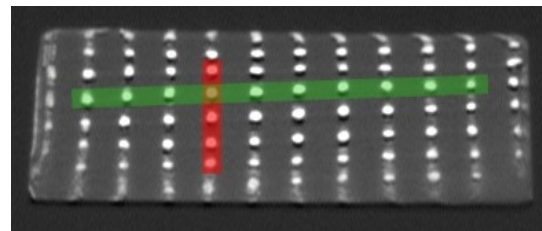
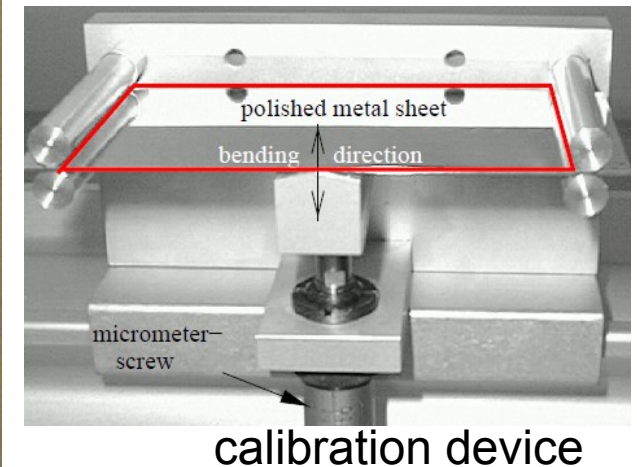
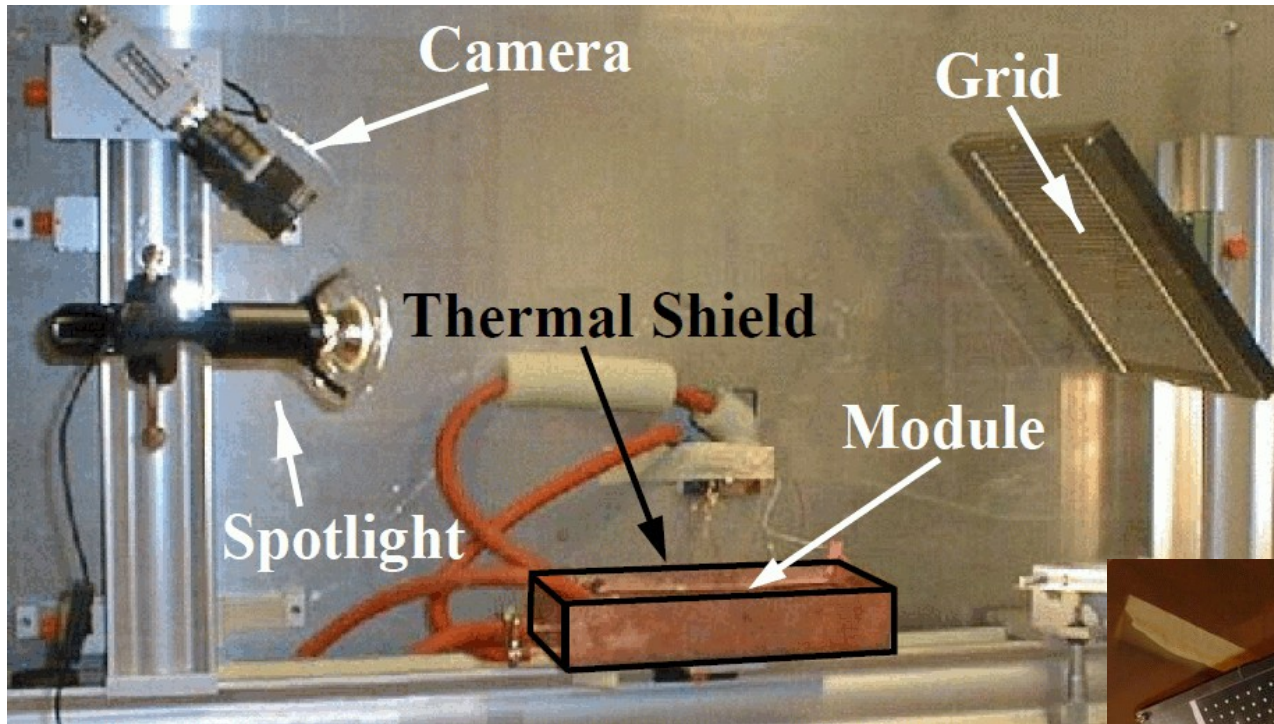
basic principle



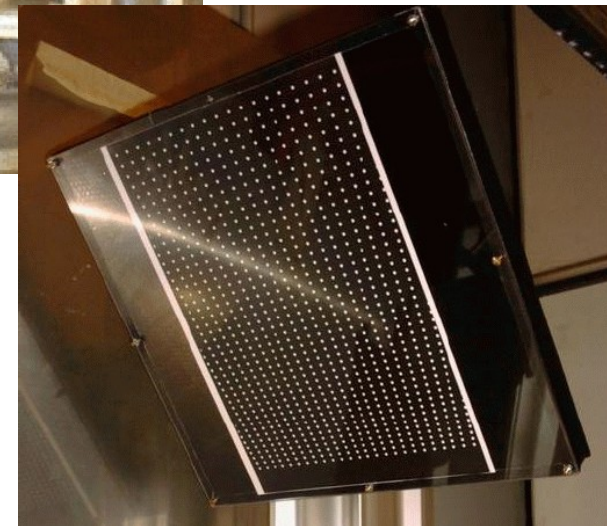
- surface under test reflects a grid of dots or LEDs, observed by a CCD
- tilt of surface elements (deformations) lead to a displacement of the dots on the CCD
- full 3D “sampled” surface reconstruction possible –
 - relative to a reference shape/image (typically at room temperature)
 - accuracy $\sim 10\ \mu\text{m}$ can be reached
 - only “intrinsic” deformation – global offsets or tilts cannot be reconstructed

the Aachen setup

Built in Aachen-1 by S. König (now PSI) 2000/1,
original idea/implementation from H.G. Moser et al. (MPI Munich)



First prototype
of FR4 hybrid
(copper coating)



the
dot
grid

plans for the DESY setup

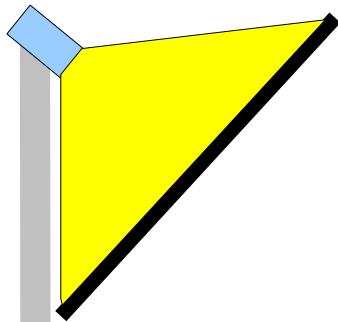
Setup parameters to be optimized in simulation -

- distances grid-sensor-camera, focal lens range (→ size of DUTs?)
- grid dimensions and spacing

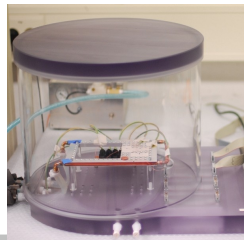
started now since software is in a useable state!

dot grid:

rigid plate with bores,
back illuminated,
adjustable tilt



alu profiles



“old” temperature setup,
elevated table (no cover)

camera:

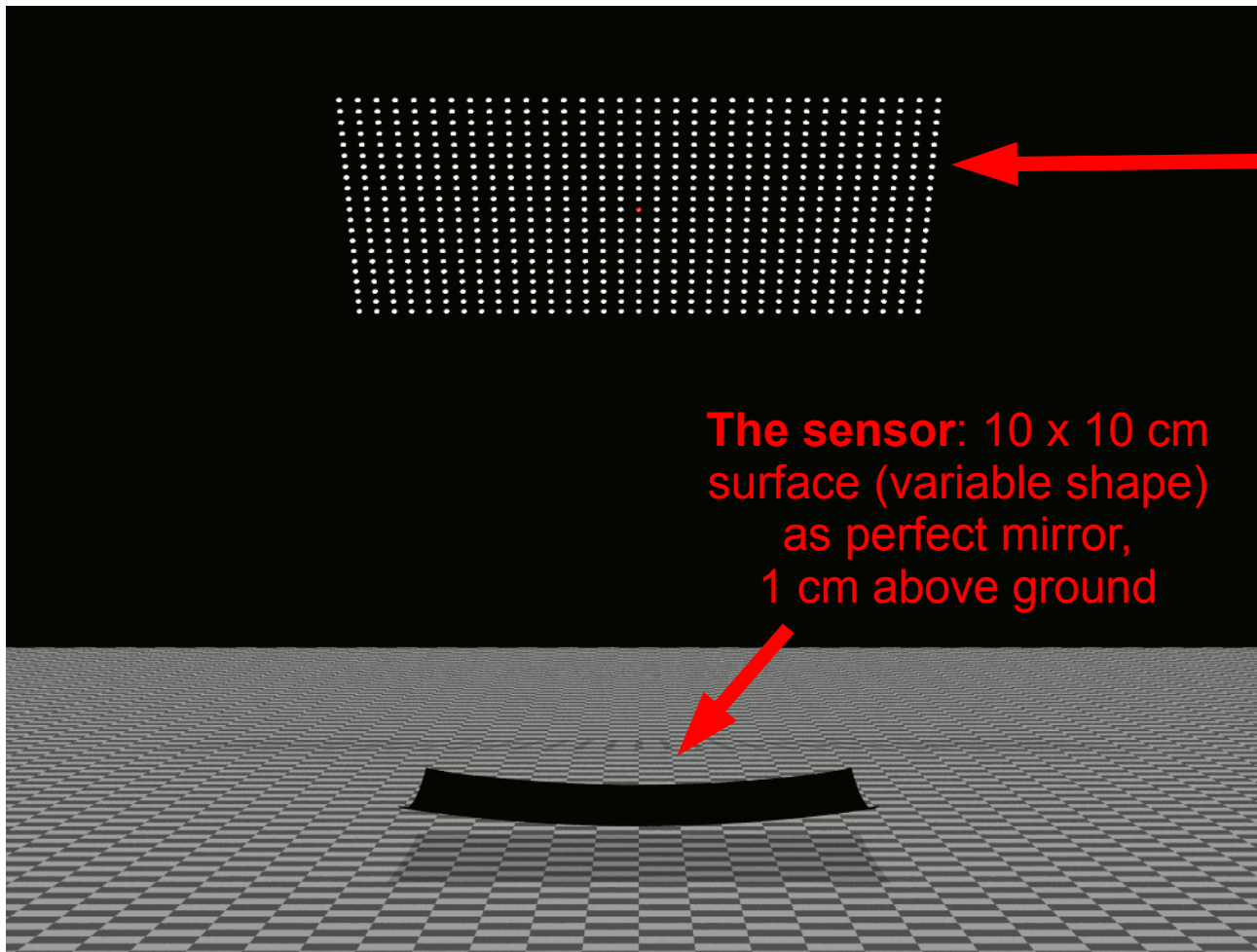
cheapest color SLR,
zoom lens ~30-100 mm,
adjustable tilt
(1° precision)



new
fast
PC

simulating the setup

Simulation is done with POV-Ray (open source raytracer program)



The dot grid: 16 x 10 cm,
33 x 21 white LEDs
(middle one is red)
80 cm away from the camera,
40 cm above the ground,
45° tilt

The sensor: 10 x 10 cm
surface (variable shape)
as perfect mirror,
1 cm above ground

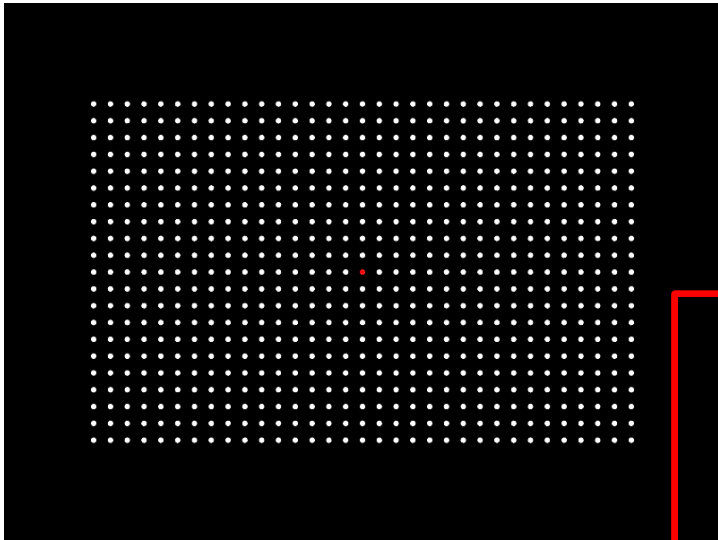
The camera:
40 cm above ground,
45° tilt,
800x600 pix (10 μ pitch),
f = 30 mm

simulating the setup



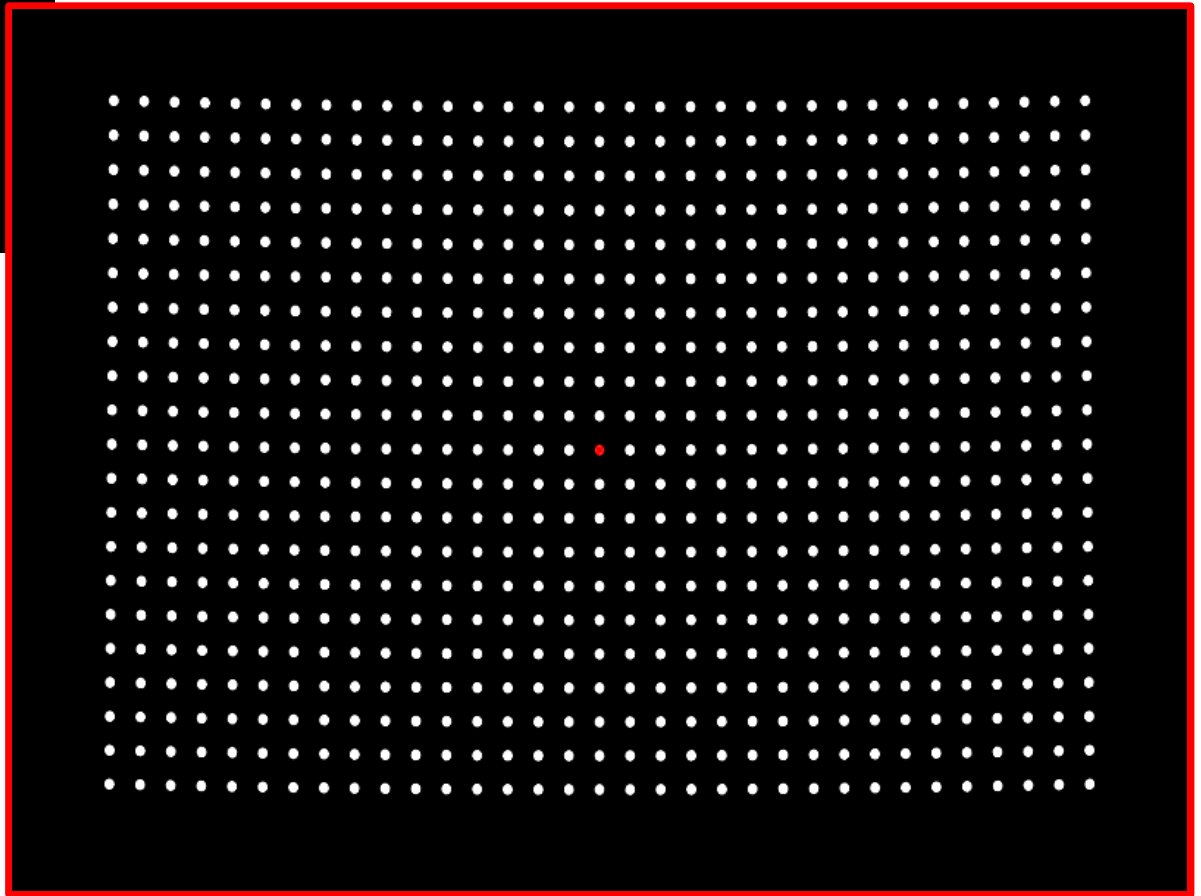
what POV-Ray is
normally used for...

surface reconstruction: raw input

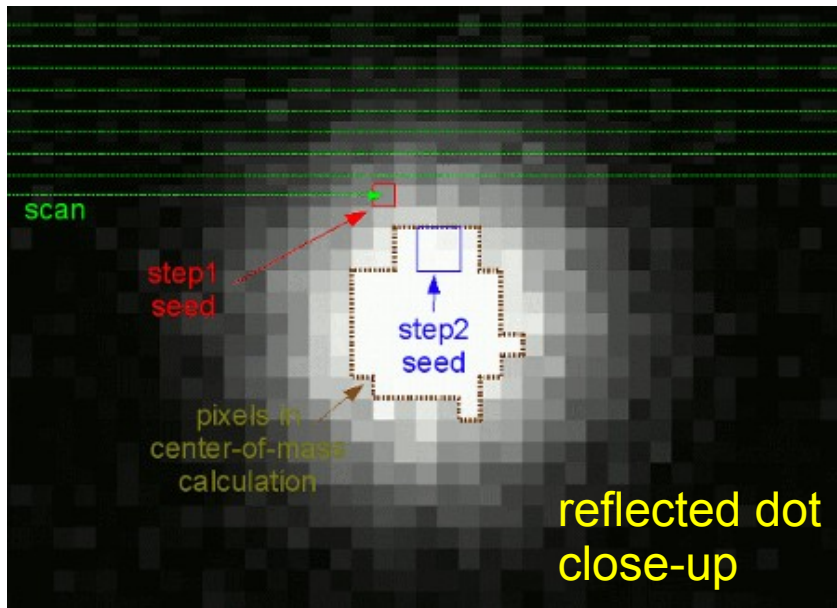


“flat” reference surface

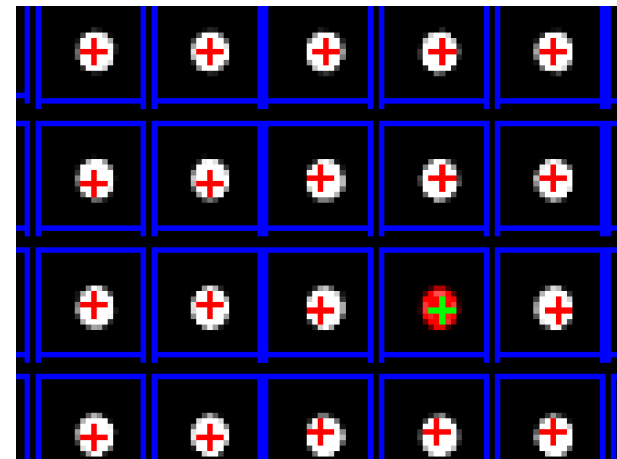
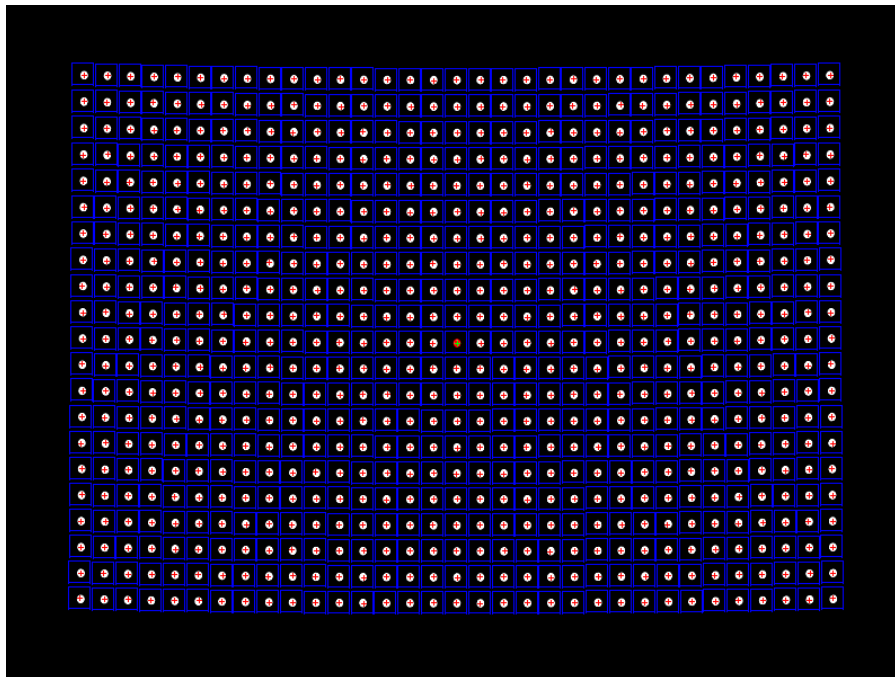
“current” image
300 μm bowing along both x,y:
 $z = 300 \mu\text{m} * (x^2 + y^2)$



surface reconstruction: point finding



- scan along x,y row-wise and compute grayscale ADC values
- stop at pixel > threshold **T1** (step1 seed)
 - evaluate group of pixels in vicinity
 - if average > threshold **T2** (step2 seed)
 - accept point
 - determine point position by center-of gravity of all pixels around seed2 with grayscale ADC > threshold **T3**
 - average red/cyan ratio of pixels to determine if the point is “red”



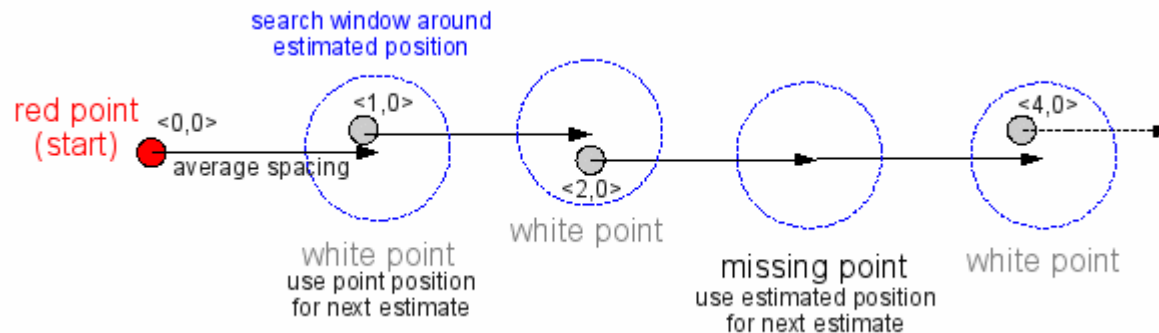
surface reconstruction: point indexing

Must consider that points might be missing:

- gaps in multi-component surfaces
- points not properly reflected (diffraction, surface quality, ...)

Indexing assigns position indices (0..N, 0..M) to the reconstructed points:

- 1:1 matching of reflected points to the grid
- red point in the middle is used as reference (0,0)
- average spacing along x and y is determined to estimate the positions of the next point(s)



Indices are used to match points in reference and “current” image

Requires proper tuning of reconstruction & setup parameters (size of search window, distance of dots in grid, etc.)

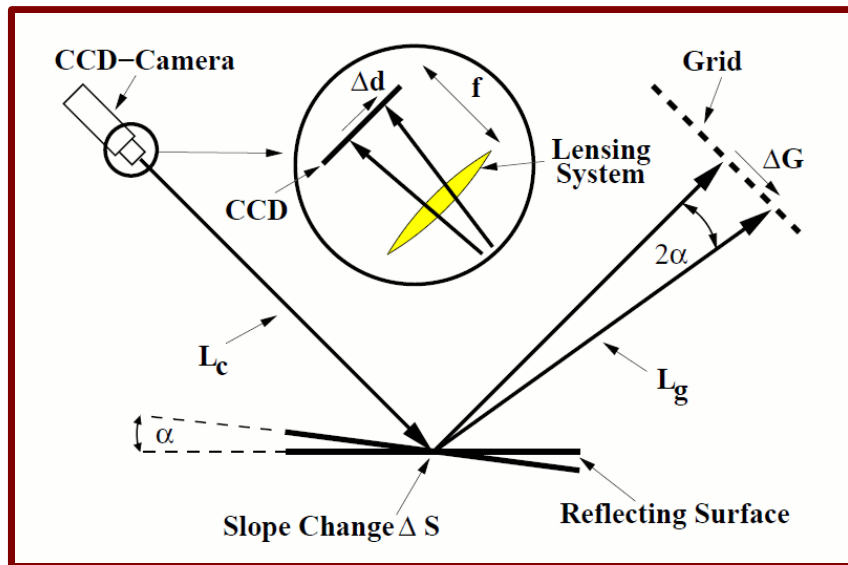
surface reconstruction: calculating the surface slope

Parameters for determining the surface slope:

- focal length of camera lens f
 - CCD pixel pitch P
 - distance camera-sensor L_c
 - distance sensor-grid L_g
- } depend on viewing angle

Point shift on sensor Δd
(between current & reference image)
is measured

$$\tan [2 \cdot \arctan (\Delta S)] \cdot L_g(\delta) = \frac{\Delta d \cdot P}{f} \cdot [L_g(\delta) + L_c(\delta)]$$



Gives the surface slope changes ΔS
between reference and current state
at the position of a point
→ spatial integration required

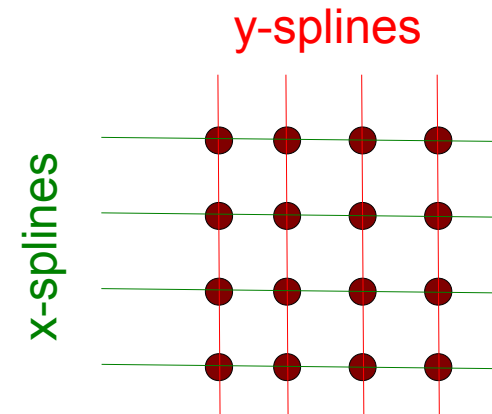
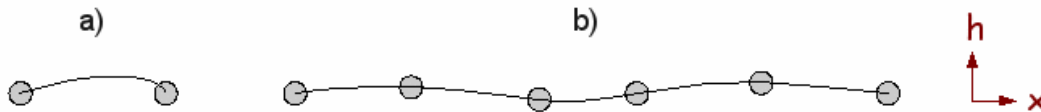
Viewing angle corrections to L_c and L_g
currently not applied (need to calculate)

surface reconstruction: spline fitting

Indexed points are grouped in “rows” (along x) and “columns” (along y)
→ fit a quadratic spline to each group

$$h(x) = A \cdot x^2 + B \cdot x + C$$

h := surface height (deformation amplitude)



For all splines along a “row” or “column” :

$$h_j(x_{j+1}) = h_{j+1}(x_{j+1}) \text{ for } j = 1..N-1 \quad \text{continuity at the intersections}$$

$$\frac{\delta h_j}{\delta x}(x_{j+1}) = \frac{\delta h_{j+1}}{\delta x}(x_{j+1}) = h_{j+1} \text{ for } j = 1..N-1 \quad \text{continuity of 1}^{\text{st}} \text{ derivative}$$

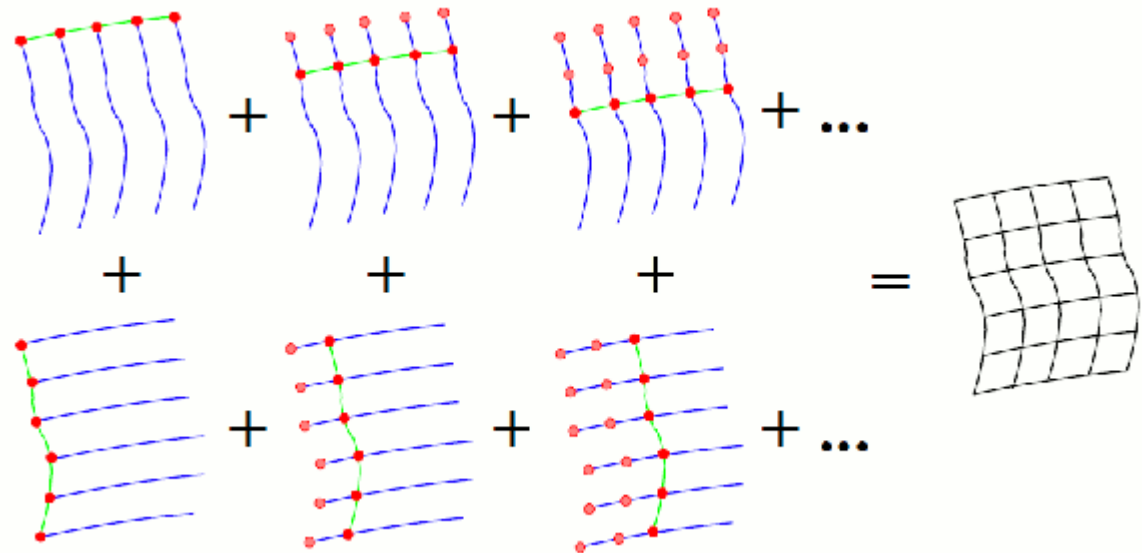
$$\frac{\delta h_1}{\delta x}(x_1) = s_1, h_1 = 0 \quad \begin{array}{l} \text{freedom of choice for global height (parameter C)} \\ \text{which cannot be reconstructed} \\ \text{since we have changes in slope } \Delta S \text{ only} \end{array}$$

→ equation system can be solved to obtain surface profile along spline

surface reconstruction: spline cross-mounting

Splines are “cross-mounted” on each other:

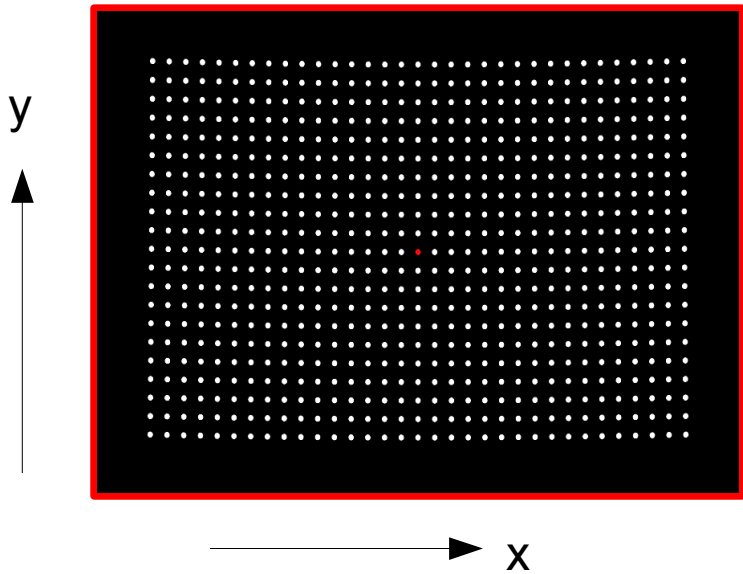
- take 1st spline along x and adjust the height of all perpendicular y-splines at the shared point (“mount” them on the x-spline)
- take 2nd spline along x ...
- ...
- repeat procedure in perpendicular direction



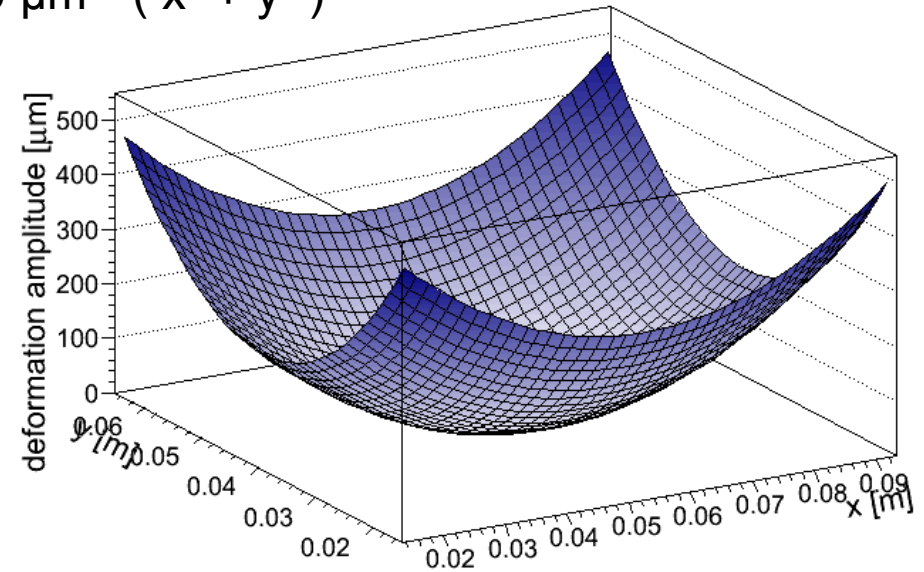
The average of all adjustments determines the global height of a spline
→ smooth surface

Finally, correct for global surface height offset (lowest point set to 0)
and tilt (rotate surface such that average normal is perpendicular to x-y-plane, TODO)

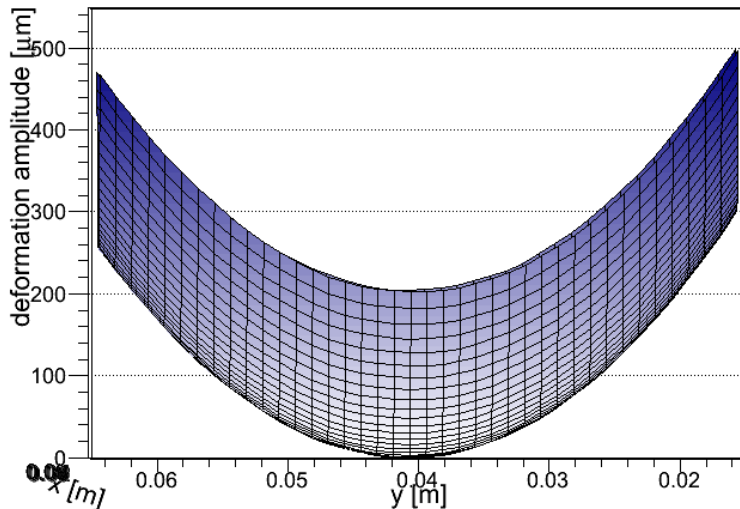
simulation examples: 300 μm bowing in x and y



Simulated surface:
 $z = 300 \mu\text{m} * (x^2 + y^2)$

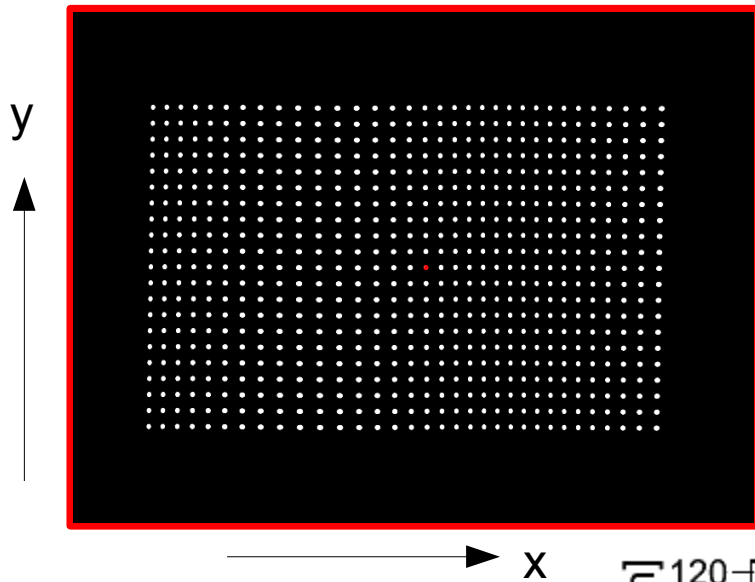


Deformation amplitude not easy to compare
since sensor is not fully illuminated with points

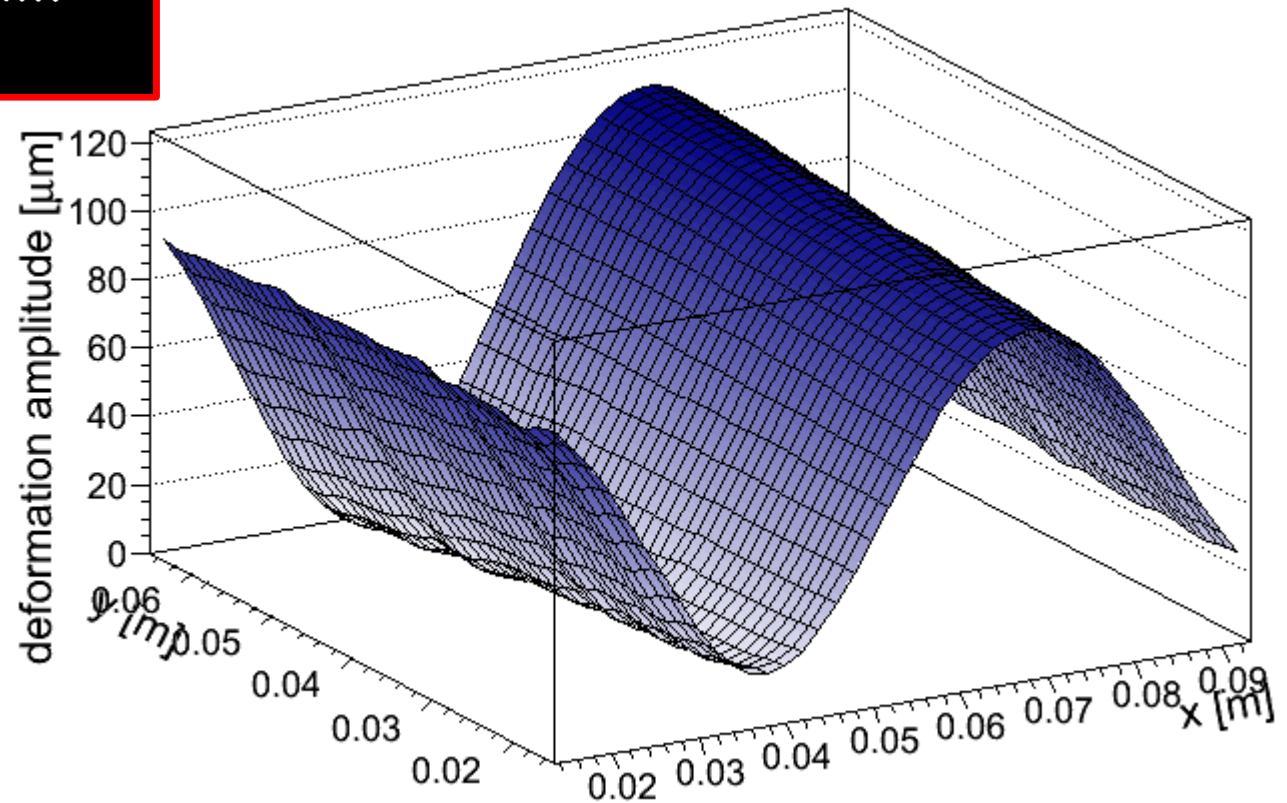


Some slight asymmetry along y (away from camera)
due to yet missing viewing angle correction
of distances

simulation examples: a sine "wave" along y



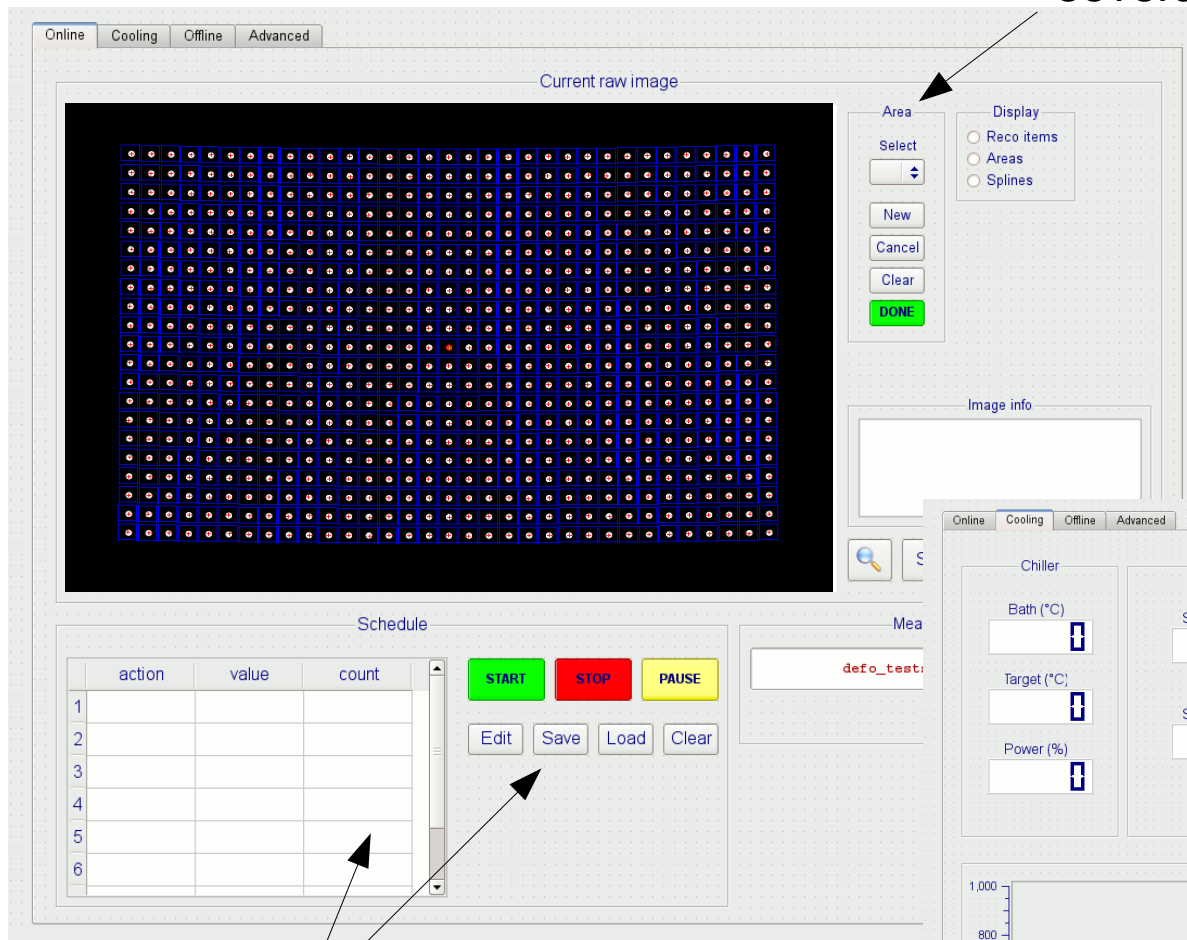
Simulated surface:
 $z = 50 \mu\text{m} * \sin(6 / \text{cm} * x)$



GUI in preparation

raw image window

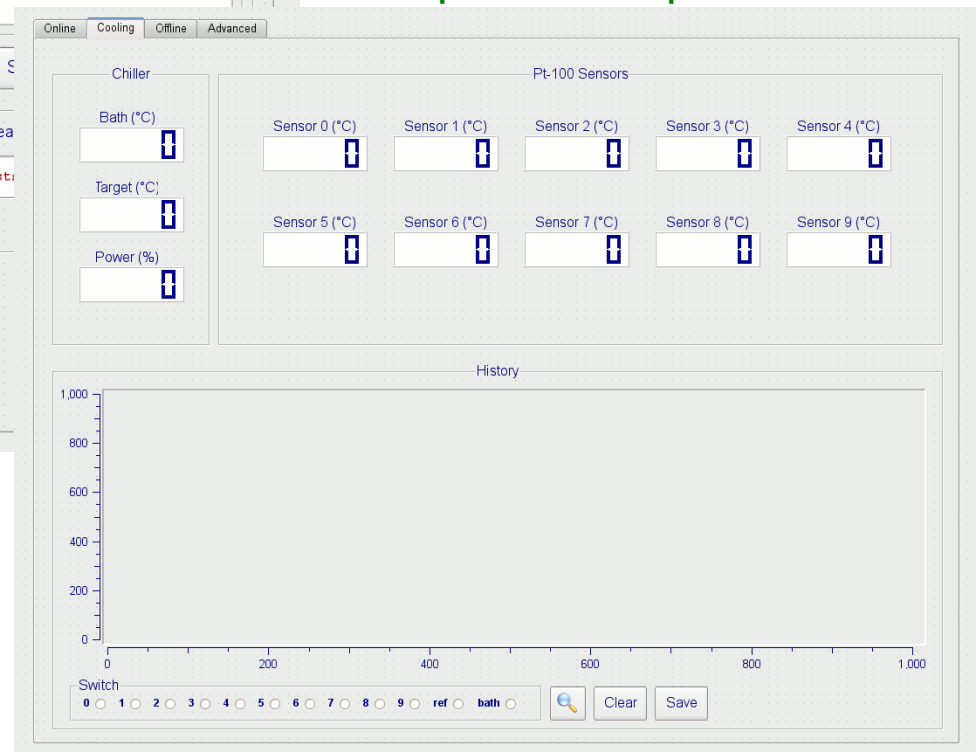
several image “areas” (parallel processing)



Devices to control:

- camera
- chiller
- multimeter (pt-100)
- reference thermometer (?)

pt-100 temp sensors



programmable
measurement
schedule